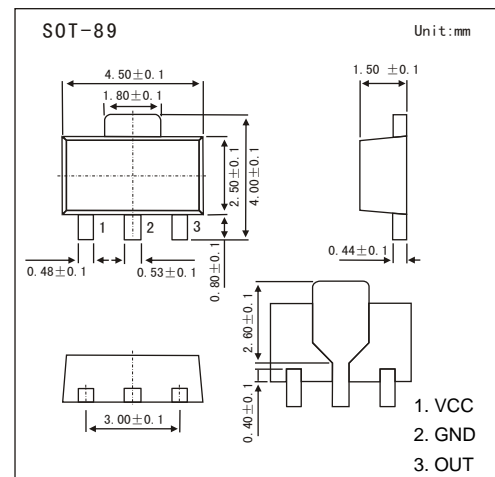


Voltage Detector KIA7029

■ Features

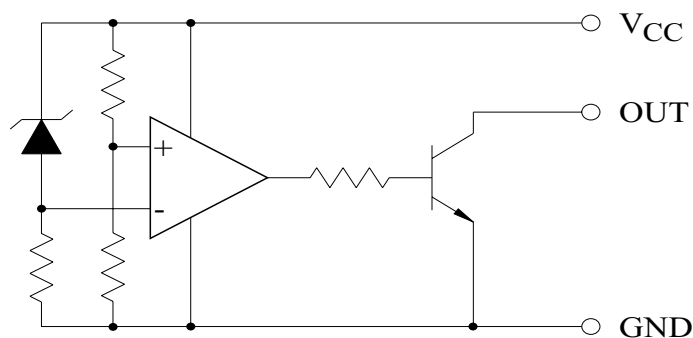
- Current Consumption is Low. $I_{cCL}=300\mu A$ Typ. $I_{cCH}=30\mu A$ Typ.
- Resetting Output Minimum Guarantee Voltage is Low 0.8V Typ.
- Hysteresis Voltage is Provided. 50mV Typ.



■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter	Symbol	Rating	Unit
Supply Voltage	V_{CC}	-0.3 to 15	V
Power Dissipation (Package Limitation)	P_D	500	mW
Operating Temperature	T_{opr}	-30 to +75	$^\circ C$
Storage Temperature	T_{STG}	-55 to +150	$^\circ C$

■ Equivalent Circuit

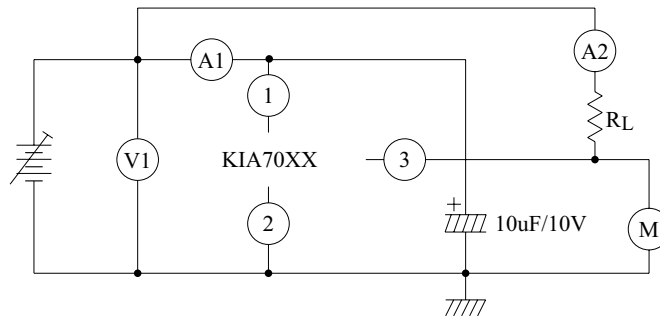


KIA7029

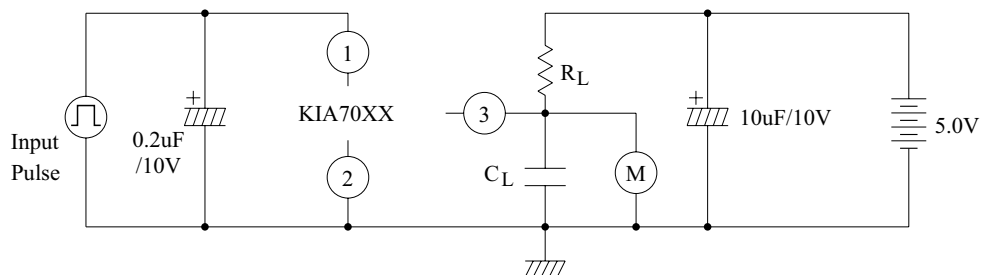
■ Electrical Characteristics ($V_{CC}=5V$, $V_{EE}=GND$, $T_a = 25^\circ C$)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Detecting Voltage (Test Circuit 1)	V_S	$V_{OL} \leq 0.4V$, $R_L=200\ \Omega$	2.75	2.9	3.05	V
Low-Level Output Voltage (Test Circuit 1)	V_{OL}	$R_L=200\ \Omega$			0.4	V
Output Leakage Current (Test Circuit 1)	I_{OH}	$V_{CC}=15V$			0.1	μA
Hysteresis Voltage (Test Circuit 1)	ΔV_S	$R_L=200\ \Omega$	30		100	mV
Detecting Voltage Temperature Coefficient	$V_S/\Delta T$	$R_L=200\ \Omega$ (Test Circuit 1)		± 0.01		$\%/^\circ C$
Circuit Current at on Time (Test Circuit 1)	I_{ccL}	$V_{CC}=V_{Smin}-.05V$		300	500	μA
Output Source Current (Test Circuit 1)	I_{ccH}	$V_{CC}=5.25V$		30	50	μA
Threshold Operating Voltage (Test Circuit 1)	V_{opr}	$V_{OL} \leq 0.4V$, $R_L=200\ \Omega$		0.8		V
L Transmission Delay Time (Test Circuit 2)	t_{pHL}	$R_L=1.0k\ \Omega$, $C_L=100pF$		10		μs
H Transmission Delay Time (Test Circuit 2)	t_{pLH}	$R_L=1.0k\ \Omega$, $C_L=100pF$		15		μs
Output Current at on Time (I) (Test Circuit 1)	$I_{oL}(I)$	$V_{CC}=V_{Smin}-.05V$, $T_c=25^\circ C$	20			mA
Output Current at on Time (II) (Test Circuit 1)	$I_{oL}(II)$	$V_{CC}=V_{Smin}-.05V$, $T_c=-30\sim+75^\circ C$	16			mA

■ Test Circuit



Test Circuit 1



Test Circuit 2